


<b>Search Notes</b> 	<b>Application/Control No.</b> 10582813	<b>Applicant(s)/Patent Under Reexamination</b> AHN ET AL.
	<b>Examiner</b> DAO H NGUYEN	<b>Art Unit</b> 2818

SEARCHED			
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SEARCH NOTES		
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US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; IBM_TDB	10/29/2008	DHN

INTERFERENCE SEARCH			
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